

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10551720	JEON ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SHIN-HON CHEN	2431

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
713	155, 156, 184, 185	9/22/08	S.C.
705	67	9/22/08	S.C.
726	9	9/22/08	S.C.

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	9/22/08	S.C.
NPL search (google)	9/22/08	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	2/13/09	S.C.

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
713	156-158,168,171,173,175	2/13/09	S.C.
726	4, 27	2/13/09	S.C.
705	67	2/13/09	S.C.

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